Search Notes				

Application/Control N	o. Applicant(s)/Patent Reexamination	under
10/562,438	INOUE ET AL.	
Examiner	Art Unit	
Ben Lewis	1745	

SEARCHED			
Class	Subclass	Date	Examiner
429	322	10/18/2006	BL
429	321	10/18/2006	BL
429	231.95	10/18/2006	BL
429	323	10/18/2006	BL

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING SE	ARCH STRATE	GY)
	DATE	EXMR
EAST	10/18/20	06 BL
Inventorship Search	10/29/200	06 BL
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